

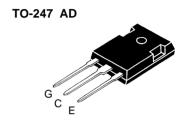
Low V_{CE(sat)} IGBT with Diode High speed IGBT with Diode **Combi Packs**

| | V _{CES} | C25 | V _{CE(sat)} |
|--------------|------------------|------|----------------------|
| IXGH10N60U1 | 600 V | 20 A | 2.5 V |
| IXGH10N60AU1 | 600 V | 20 A | 3.0 V |



| Symbol | Test Conditions | Maximum Ratings | | |
|-----------------------------------|---|--|-----------|--|
| V _{CES} | T _J = 25°C to 150°C | 600 | V | |
| $\mathbf{V}_{\mathtt{CGR}}$ | $T_{_J}$ = 25°C to 150°C; $R_{_{GE}}$ = 1 $M\Omega$ | 600 | V | |
| V _{GES} | Continuous | ±20 | V | |
| $V_{\scriptscriptstyle{\sf GEM}}$ | Transient | ±30 | V | |
| I _{C25} | T _C = 25°C | 20 | A | |
| I _{C90} | $T_{c} = 90^{\circ}C$ | 10 | Α | |
| I _{CM} | $T_{\rm C}$ = 25°C, 1 ms | 40 | Α | |
| SSOA (RBSOA) | V_{GE} = 15 V, T_{VJ} = 125°C, R_{G} = 150 Ω Clamped inductive load, L = 300 μ H | I _{CM} = 20 @ 0.8 V _{CES} | А | |
| P _c | T _C = 25°C | 100 | W | |
| T _J | | -55 + 150 | °C | |
| T_{JM} | | 150 | °C | |
| T _{stg} | | -55 + 150 | °C | |
| M _d | Mounting torque (M3) | 1.13/10 | Nm/lb.in. | |
| Weight | | 6 | g | |
| | ad temperature for soldering 62 in.) from case for 10 s | 300 | °C | |

| Symbol | Test Conditions | Ch (T _J = 25°C, unless min . | otherwi | ristic Va se speci max. | |
|----------------------|--|--|---------|-------------------------------|----------|
| BV _{CES} | $I_{C} = 750 \ \mu\text{A}, \ V_{GE} = 0 \ \text{V}$ | 600 | | | V |
| $V_{\rm GE(th)}$ | $I_{_{C}} = 500 \; \mu\text{A}, \; V_{_{CE}} = V_{_{GE}}$ | 2.5 | | 5.5 | V |
| I _{CES} | $V_{CE} = 0.8 \bullet V_{CES}$ $V_{GE} = 0 V$ | $T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$ | | 260 2.5 | μA mA |
| I _{GES} | $V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$ | | | ±100 | nA |
| V _{CE(sat)} | $I_{\rm C} = I_{\rm C90}, V_{\rm GE} = 15 \text{ V}$ | 10N60U1 10N60AU1 | | 2.5 3.0 | V |



G = Gate, C = Collector, E = Emitter, TAB = Collector

Features

- · International standard package JEDEC TO-247 AD
- · IGBT and anti-parallel FRED in one package
- 2nd generation HDMOS™ process
- Low $\mathbf{\tilde{V}}_{\text{CE(sat)}}$ for low on-state conduction losses
- MOS Gate turn-on
 - drive simplicity
- Fast Recovery Epitaxial Diode FRED)
 - soft recovery with low $\boldsymbol{I}_{_{\boldsymbol{R}\boldsymbol{M}}}$

Applications

- · AC motor speed control
- · DC servo and robot drives
- · DC choppers
- Uninterruptible power supplies (UPS)
- · Switch-mode and resonant-mode power supplies

Advantages

- · Space savings (two devices in one package)
- Easy to mount with 1 screw (isolated mounting screw hole)
- · Reduces assembly time and cost

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IXGH10N60U1 IXGH10N60AU1

LIXYS

| Symbol | Test Conditions Characteristic Values $(T_{\perp} = 25^{\circ}C, \text{ unless otherwise specified})$ | | | |
|--|---|--|--|--|
| | min. | typ. | max. | |
| g _{fs} | $I_{_{C}}=I_{_{C90}};~V_{_{CE}}=10~V,~4$ Pulse test, t \leq 300 μs , duty cycle \leq 2 % | 8 | S | |
| C _{ies} C _{oes} C _{res} | | 750 125 30 | pF pF pF | |
| $\mathbf{Q}_{\mathbf{g}_{\mathbf{g}_{\mathbf{c}}}}$ $\mathbf{Q}_{\mathbf{g}_{\mathbf{c}}}$ | | 50 15 25 | 70 nC 25 nC 45 nC | |
| t _{d(on)} t _{ri} E _{on} | Inductive load, T_J = 25°C $ \begin{vmatrix} I_C = I_{C90}, V_{GE} = 15 \text{ V}, L = 100 \mu\text{H} \\ V_{CE} = 0.8 V_{CES}, R_G = R_{off} = 150 \Omega \end{vmatrix} $ | 100 200 0.4 | ns ns mJ | |
| t _{d(off)} t _{fi} E _{off} | $\begin{cases} \text{Switching times may increase} \\ \text{for V}_{\text{CE}} \text{ (Clamp)} > 0.8 \bullet \text{V}_{\text{CES}}, \\ \text{higher T}_{\text{J}} \text{ or increased R}_{\text{G}} \end{cases} 10\text{N}60\text{AU1}$ | 600 300 0.6 | ns ns mJ | |
| $\begin{aligned} & \mathbf{t}_{d(on)} \\ & \mathbf{t}_{ri} \\ & \mathbf{E}_{on} \\ & \mathbf{t}_{d(off)} \\ & \mathbf{t}_{fi} \end{aligned}$ | $eq:local_$ | 100 200 1 900 570 360 2.0 1.2 | ns ns mJ 1500 ns 2000 ns 600 ns mJ mJ | |
| R _{thJC} | | 0.25 | 1.25 K/W K/W | |

TO-247 AD Outline Q A1 -1 = Gate 2 = Collector 3 = EmitterTab = Collector .087 .059 .040 A₁

Reverse Diode (FRED)

Characteristic Values

(T_J = 25°C, unless otherwise specified)

| Symbol | lest Conditions m | ın. | typ. | max. | |
|------------------------------------|--|-----|------------------|------|---------------|
| V _F | $I_F = I_{C90}, \ V_{GE} = 0 \ V,$ Pulse test, $t \le 300 \ \mu s$, duty cycle $d \le 2 \ \%$ | | | 1.75 | V |
| I _{RM} t _{rr} | $\begin{cases} I_F = I_{C90}, \ V_{GE} = 0 \ V, \ -di_F/dt = 64 \ A/\mu s \\ V_R = 360 \ V & T_J = 100^{\circ} \\ I_F = 1 \ A; \ -di/dt = 50 \ A/\mu s; \ V_R = 30 \ V & T_J = 25^{\circ} \end{cases}$ | Ď. | 2.5 165 35 | 50 | A ns ns |
| R _{thJC} | | | | 2.5 | K/W |



Fig. 1 Saturation Characteristics

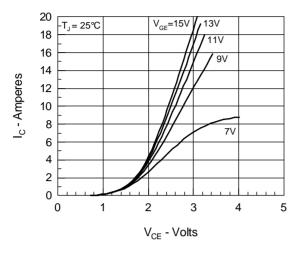


Fig. 3 Collector-Emitter Voltage vs. Gate-Emitter Voltage

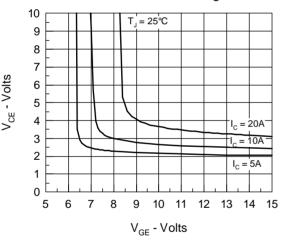


Fig. 5 Input Admittance

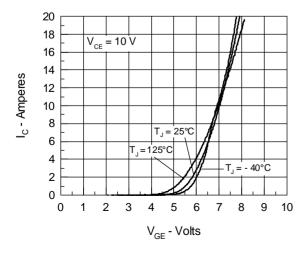


Fig. 2 Output Characterstics

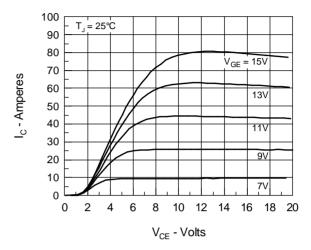


Fig. 4 Temperature Dependence of Output Saturation Voltage

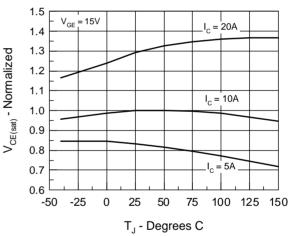


Fig. 6 Temperature Dependence of Breakdown and Threshold Voltage

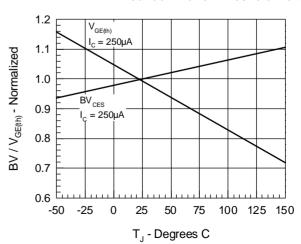




Fig.7 Gate Charge

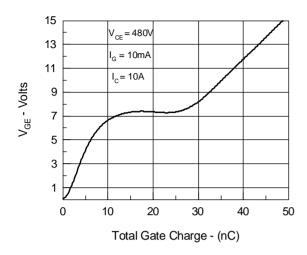


Fig.9 Capacitance Curves

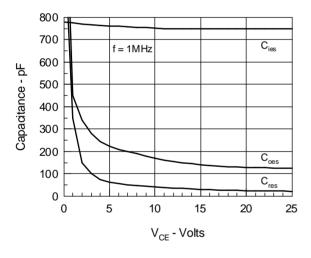
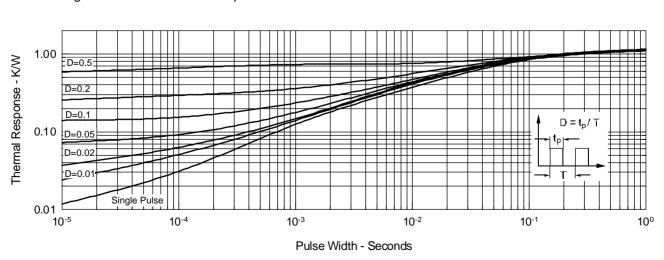


Fig.10 Transient Thermal Impedance



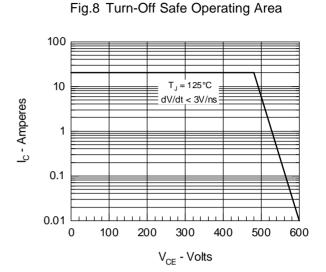


Fig.11 Maximum Forward Voltage Drop

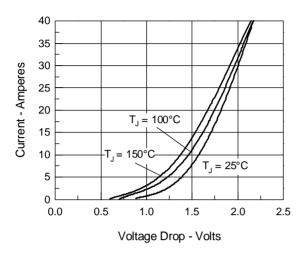


Fig.13 Junction Temperature Dependence off I... and Q

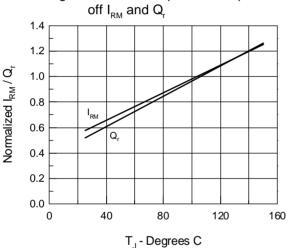


Fig.15 Peak Reverse Recovery Current

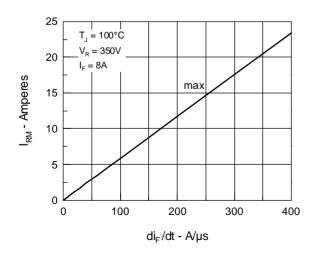


Fig.12 Peak Forward Voltage V_{FR} and Forward Recovery Time t_{FR}

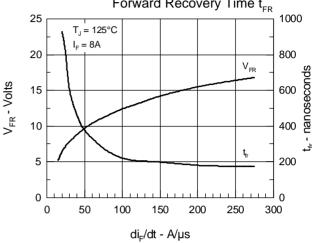


Fig.14 Reverse Recovery Charge

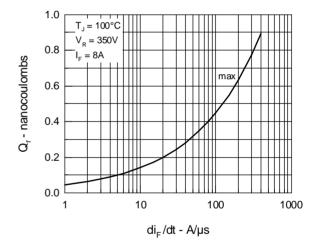


Fig.16 Reverse Recovery Time

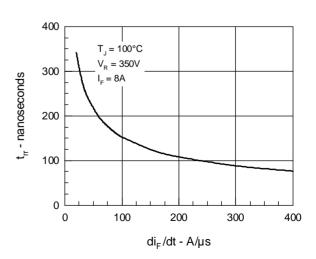
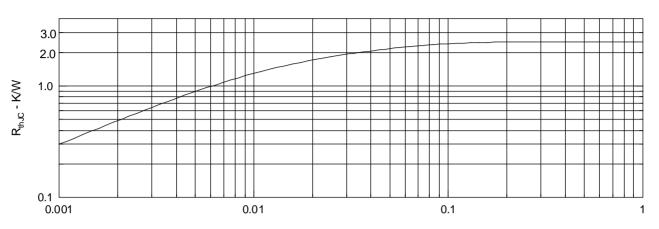




Fig.17 Diode Transient Thermal resistance junction to case



Pulse Width - Seconds